

Description

The AP20P02DF uses advanced trench technology

to provide excellent $R_{\text{DS(ON)}}$, low gate charge and

operation with gate voltages as low as 2.5V. This

device is suitable for use as a

Battery protection or in other Switching application.



 $V_{DS} = -20V I_{D} = -20A$

 $R_{DS(ON)} < 9m\Omega$ @ V_{GS} =-10V

Application

Battery protection

Load switch

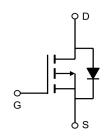
Uninterruptible power supply

Package Marking and Ordering Information

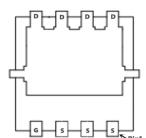
Product ID	Pack	Marking	Qty(PCS)
AP20P02DF	PDFN3*3-8L	20P30	3000

Absolute Maximum Ratings (TA=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	-20	V
Vgs	Gate-Source Voltage	±8	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ -4.5V ¹	-20	Α
I _D @T _C =70°C	Continuous Drain Current, V _{GS} @ -4.5V ¹	-18	Α
Ідм	Pulsed Drain Current ²	-100	Α
P _D @T _C =25°C	Total Power Dissipation ³	29	W
P _D @T _C =70°C	Total Power Dissipation ³	19	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
R ₀ JA	Thermal Resistance Junction-Ambient ¹	75	°C/W
R ₀ JA	Thermal Resistance Junction-Ambient ¹ (t ≤10s)	40	°C/W
Rejc	Thermal Resistance Junction-Case ¹	4.2	°C/W











Electrical Characteristics (TA=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-20	-24		V
2BVpss/2TJ	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.012		V/°C
		V _{GS} =-4.5V , I _D =-10A		6.5	9	
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =-2.5V , I _D =-8A		8.7	11.5	mΩ
		V _{GS} =-1.8V , I _D =-6A		13	15	
V _G S(th)	Gate Threshold Voltage		-0.3	-0.6	-1.0	V
₹VGS(th)	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =-250uA		2.94		mV/°C
IDSS	Drain-Source Leakage Current	V _{DS} =-20V , V _{GS} =0V , T _J =25°C			1	uA
Igss	Gate-Source Leakage Current	V _{GS} =±8V , V _{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-10A		43		S
Qg	Total Gate Charge (-4.5V)			63		
Qgs	Gate-Source Charge	V _{DS} =-15V , V _{GS} =-4.5V , I _D =-		9.1		nC
Qgd	Gate-Drain Charge			13		
T _{d(on)}	Turn-On Delay Time			15.8		
Tr	Rise Time	V _{DD} =-10V , V _{GS} =-4.5V ,		76.8		
T _{d(off)}	Turn-Off Delay Time	R _G =3.3 , I _D =-10A		193		ns
Tf	Fall Time			186.4		
Ciss	Input Capacitance			5783		
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		509		рF
Crss	Reverse Transfer Capacitance			431		
Is	Continuous Source Current ^{1,4}	V _G =V _D =0V , Force Current			-10.7	Α
Ism	Pulsed Source Current ^{2,4}				-60	Α
Vsp	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1.2	V
trr	Reverse Recovery Time	IF=-10A , dI/dt=100A/μs ,		27		nS
Qrr	Reverse Recovery Charge	T _J =25°C		17.8		nC

Note

^{1.}The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

^{2.}The data tested by pulsed , pulse width $\,\leq\,300\text{us}$, duty cycle $\,\leq\,2\%$

^{3.}The power dissipation is limited by 150 $^{\circ}$ C junction temperature

^{4.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

-20V P-Channel Enhancement Mode MOSFET

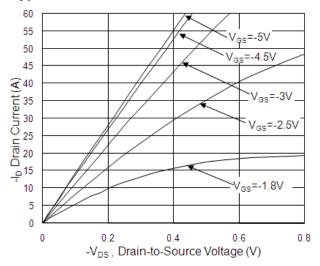


Fig.1 Typical Output Characteristics

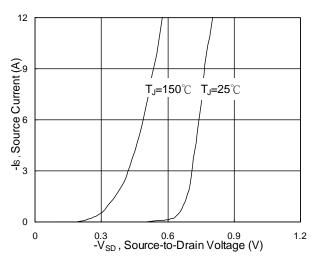


Fig.3 Forward Characteristics of Reverse

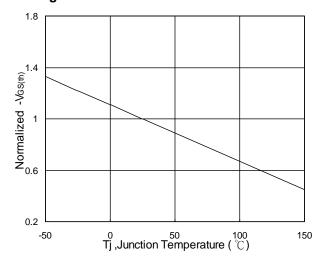


Fig.5 Normalized V_{GS(th)} vs. T_J

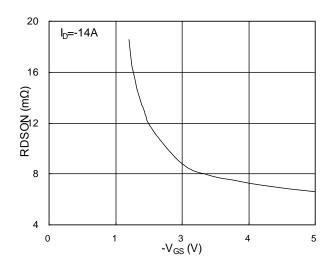


Fig.2 On-Resistance vs. G-S Voltage

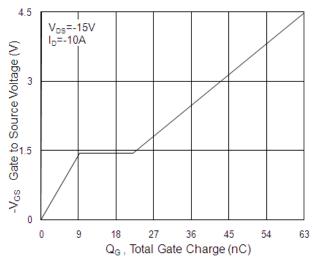


Fig.4 Gate-charge Characteristics

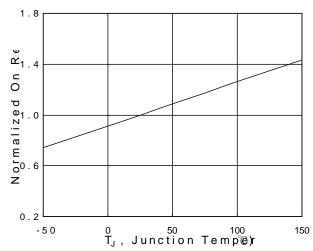
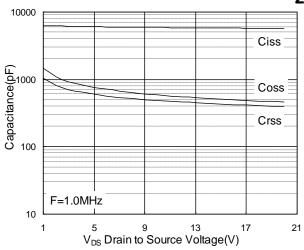


Fig.6 Normalized RDSON vs. TJ







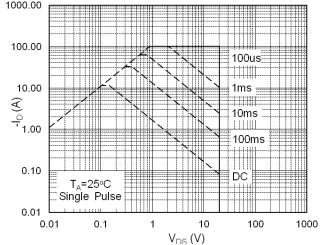


Fig.7 Capacitance

Fig.8 Safe Operating Area

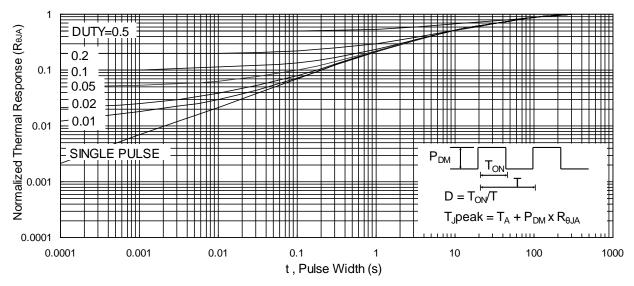
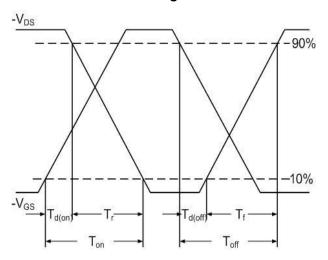


Fig.9 Normalized Maximum Transient Thermal Impedance



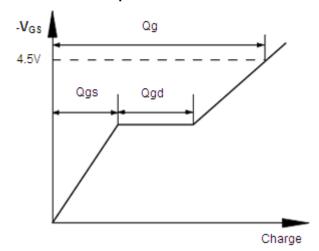
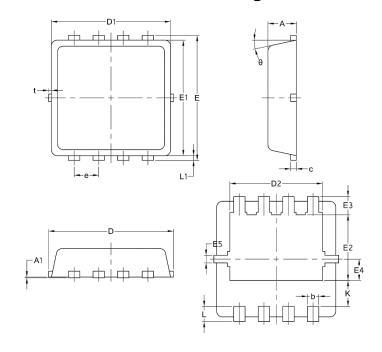


Fig.10 Switching Time Waveform

Fig.11 Gate Charge Waveform



Package Mechanical Data-DFN3*3-8L-JQ Single



	Common mm			
Symbol				
	Mim	Nom	Max	
Α	0.70	0.75	0.85	
A1	/	/	0.05	
b	0.20	0.30	0.40	
С	0.10	0.152	0.25	
D	3.15	3.30	3.45	
D1	3.00	3.15	3.25	
D2	2.29	2.45	2.65	
E	3.15	3.30	3.45	
E1	2.90	3.05	3.20	
E2	1.54	1.74	1.94	
E3	0.28	0.48	0.65	
E4	0.37	0.57	0.77	
E5	0.10	0.20	0.30	
e	0.60	0.65	0.70	
K	0.59	0.69	0.89	
L	0.30	0.40	0.50	
L1	0.06	0.125	0.20	
t	0	0.075	0.13	
Ф	10	12	14	



-20V P-Channel Enhancement Mode MOSFET Attention

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